

Crystal Clock Oscillator Specification

IQD Part No. + Packaging: LFSPXO083320RL3K Wurth Part No. **830208332009**

Description

- LVDS output crystal oscillator in a hermetically sealed ceramic package with a seam sealed metal lid.
- Model IQXO-618-33
- Model Issue number
- Note: Operating temperature ranges -40 to 105°C and -40 to 125°C are intended for industrial use and not for safety critical applications such as automotive. Please contact IQD for alternative options.

Frequency Parameters

Frequency

156.250MHz ±50.00ppm

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- Frequency Stability ±5 Operating Temperature Range -4
- Ageing

ange -40.00 to 105.00°C ±3ppm max per year at 25°C

3.3V ±5%

50.000mA

Electrical Parameters

- Supply Voltage
- Current Draw

Output Details

Output Compatibility

Drive Capability

100Ω

LVDS

- Rise & Fall Time (20 80%)
 0.5ns max
- Duty Cycle 45/55%
- Differential Output Voltage (VOD): 0.247V min, 0.33V typ, 0.454V max
- Offset Voltage (VOS): 1.125V min, 1.25V typ, 1.375V max.Output Voltage Levels:
- Output Low (VOL): 0.9V min Output High (VOH): 1.6V max

Output Control

Standby Operation:

Logic '1' (\geq 70% Vs) to pad 1 enables oscillator output. Logic '0' (\leq 30% Vs) to pad 1 disables oscillator output; when disabled the oscillator output goes to the high impedance state.

No connection to pad 1 enables oscillator output.

- Start-up Time: 10ms max
- Standby Current: 10µA max

Noise Parameters

Phase Jitter (12kHz to 20MHz): 1ps rms max



Outline (mm)



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Environmental Parameters

- Storage Temperature Range: -55 to 125°C
- Drop Test (JIS-C0044): the specimen is measured for frequency before the test. It is then dropped from a height of 100cm min as a free fall object onto a hard wooden plate of thickness 30mm min.
- Vibration (MIL-STD-883F : 2007.3): the specimen is measured for frequency before the test. Test in X,Y and Z axes for the vibration test. Frequency range: 20~2000Hz, peak to peak amplitude: 1.52mm, peak acceleration: 20G, sweep time: 20 minute/axis, pendicular total test time: 4 hours.
- Low Temp Exposure (JIS-C0020): the specimen is measured for frequency before the test. Expose device to -40°C±3°C for 168±6 hours. Measure electrical performance after leaving 1~2 hours at room temperature.
- Ageing Test (JIS-C0021): the specimen is measured for frequency before the test. Expose device to +125°C±3°C for 720±48 hours. Measure electrical performance after leaving 1~2 hours at room temperature.
- High Temperature and Humidity (MIL-STD-883F : 1004.7): the specimen is measured for frequency before the test. Expose device to +85°C±5°C and 85±5% humidity for 168±6 hours. Measure electrical performance after leaving 1~2 hours at room temperature.
- Temperature Cycle Test (MIL-STD-883F : 1010.8): the specimen is measured for frequency before the test. Expose device to 100 cycles of: Low temp: -55°C±3°C for15±3 min Ramp up to high temp: 2-3 mins High temp:+125°C±3°C for15±3 min Ramp down to low temp: 2-3 mins Measure electrical performance after leaving 1~2 hours at room temperature.
 RoHS Terminations
- RoHS Reflow Temp
 260°C max for 10s max

Compliance

- RoHS Status (2011/65/EU)
- REACh Status

Compliant Not Applicable

Compliant

MSL Rating (JDEC-STD-033): No

Packaging Details

- Pack Style: RL3K Tape & reel in accordance with EIA-481-D Pack Size: 3,000
- Alternative packing option available

USEFUL LINKS

Toolbox: www.we-online.com/toolbox

Product Catalog: www.we-online.com/products

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